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Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/687,930	YOSHIOKA ET AL.	
Examiner	Art Unit	
Sophia S. Chen	2852	

	SEARCHED		
Class	Subclass	Date	Examiner
399	162	6/13/2005	sc
	302	(updat	ed)
	308		
	303		
	312		
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	320		
428	57, 58		
	59, 60		
	61, 62		
474	253		
	254	V	V

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
as	bove	6/13/2005	sc
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE		
None	6/13/200	05 SC	